15. Ripple Attenuator Module (RAM™ / MI-RAM™)

Overview

The RAM/MI-RAM is an accessory product for VI-/MI-200, VI-/MI-J00, MegaMod/MI-MegaMod, ComPAC/MI-ComPAC and FlatPAC. It reduces line frequency related ripple and converter switching noise to less than 3mV_p-p (10mV_p-p on the VI-J00).

Features include:

- Reduced differential noise (<3mV_p-p at loads up to 20A). The input of the RAM must be between 5 – 50V_DC.
- Active and passive filtering
- Attenuation of low frequency input power source harmonics and high frequency switching components from DC-20MHz
- Remote sense, trim, overvoltage protection and overcurrent protection features retained

Applications for the RAM include medical diagnostic and automated test equipment, radio receivers, transmitters and communication products, and other products requiring the noise performance of a linear supply. Refer to RAM operation in Section 9.

The RAM is a combination active / passive filter. A simplified schematic is shown in Figure 15.2. The output of the switcher feeds directly into a high frequency passive filter which attenuates the switching noise. Low frequency, line related ripple attenuation is via a FET series regulator that maintains a constant average forward voltage drop of about 350mV. The FET gate is modulated to maintain the AC component of the FET drain-source voltage equal to the ripple component of the incoming DC voltage, effectively cancelling it out.

The power supply’s sense leads feed through the RAM for connection at the RAM output, for local sense, or at the load, for remote sense (converter compensation is 0.5V maximum). The attenuation and insertion loss are constant up to 10A or 20A, depending on model. In overload (above 10A or 20A), the voltage drop will increase as the current increases. A single RAM can be used on any output from 5 – 50V_DC and will maintain the original output set point of the converter within 0.5% at the sense connection. Care should be taken not to connect IN to OUT pins (i.e., through scope probe returns, grounds, etc.) as attenuation will be adversely affected.

Inserting the RAM into the output leads of a Vicor VI-200/VI-J00 converter adds phase shift to the converter’s control loop. This occurs because voltage is sensed at the output of the RAM’s internal filter. The 220µF capacitor between –S_IN and –IN (See Figure 15.1) provides additional high-frequency bypassing for the sense leads to ensure stability of the converter and RAM. It may be possible to reduce its value or remove it in applications where transient response is important. If it is removed a network analyzer should be used to verify stable operation.

![Figure 15.2 — Basic RAM schematic](image)

![Figure 15.3 — Attenuation vs. frequency (typical)](image)